

FORM PTO-1449 Receipt date: 01/25/2007		U.S. Department of Commerce Patent and Trademark Office		Atty. Docket No. P29883	Application No. 10/577,619		
INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Use several sheets if necessary)				Applicant Dieter LEHMANN et al.			
				I.A. Filing Date October 22, 2004		Group Unknown	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
/N.M.B./		5 5 7 6 1 0 6	11/19/96	KERBOW et al.			
		4 8 3 5 1 3 0	05/24/83	MOLINSKI et al.			
		3 2 9 8 9 4 2	05/20/58	MAGAT et al.			01/19/04
		6 3 8 7 9 6 4	05/14/02	D'AGOSTINO et al.			
		6 2 2 5 3 6 8	05/01/01	D'AGOSTINO et al.			
		5 7 5 6 1 9 9	05/26/98	KERBOW et al.			
	↓	6 7 7 0 3 7 8	08/03/04	LEHMANN			
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES      NO
/N.M.B./		1 5 1 6 6 4 8	07/05/78	GREAT BRITAIN			
	9	6 / 0 3 4 4 8	02/08/96	W.I.P.O.			
		1 4 6 7 1 6	10/22/79	GERMANY			
		2 3 1 8 8 9 6	02/18/77	FRANCE			
	2004	- 1 0 7 4 6 1	04/08/04	JAPAN			
		1 9 8 2 3 6 0 9	12/02/99	GERMANY			
	9	9 / 6 1 5 2 7	12/02/99	W.I.P.O.			
	63	- 0 0 7 4 5 5	01/13/88	JAPAN			
	↓	2 4 9 4 7 0 2	05/28/82	FRANCE			
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)							
/N.M.B./	1	A. Heger et al., Technologie der Strahlenchemie an Polymeren, Akademie-Verlag Berlin 1990, 463-488 and 496-501.					
	2	Ferse et al., Plaste u. Kautschuk, 29 (1982), 45-465.					
	3	K. Schierholz et al., J. Polym. Sci. Part B, Polymer Physics, Vol. 37, 2404-2411 (1999).					
	4	English Language Abstract of FR 2318896. date unknown					
	5	English Language Abstract of JP 2004-107461. date unknown					
	6	Dargaville et al., "High Energy Radiation Grafting Of Fluoropolymers", Prog. Poly. Sci. 28 (2003) 1355-1376.					
	7	English Language Abstract of JP 63-007455. date unknown					
	8	Patent Abstracts of Japan, Vol. 011, No. 222 (C-435), July 18, 1987					
	9	Patent Abstracts of Japan, Vol. 2003, No. 03, May 5, 2003					
	10	Patent Abstracts of Japan, Vol. 014, No. 252 (E-0934), May 20, 1990					
EXAMINER		DATE CONSIDERED					
<p>*EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</p>							